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Complete if Known

Application Number	09/944981
Filing Date	August 30, 2001
First Named Inventor	Ahn, Kie
Group Art Unit	2812
Examiner Name	Walter L. Lindsay

Sheet 1 of 1

Attorney Docket No: 01303.021US1

US PATENT DOCUMENTS

Examiner Initial *	USP Document Number	Publication Date	Name of Patentee or Applicant of cited Document	Class	Subclass	Filing Date If Appropriate
WLL	US-02/0089023	07/11/2002	Yu, Z. , et al	257	411	01/05/2001
WLL	US-4,215,156	07/29/1980	Dalal, H. , et al	427	84	08/26/1977
WLL	US-4,333,808	06/08/2002	Bhattacharyya, A. , et al	204	192 D	02/13/1981
WLL	US-4,647,947	03/03/1987	Takeoka, , et al	346	135.1	09/13/1985
WLL	US-4,920,071	04/24/1990	Thomas, Michael	437	188	08/18/1987
WLL	US-5,795,808	08/18/1998	Park, Bo	438	301	11/12/1996
WLL	US-5,801,105	09/01/1998	Yano, Y. , et al	438	785	06/14/1996
WLL	US-5,810,923	09/22/1998	Yano, Y. , et al	117	84	05/10/1996
WLL	US-5,822,256	10/13/1998	Bauer, Mark , et al	365	200	03/05/1997
WLL	US-6,013,553	01/11/2000	Wallace, Robert , et al	438	287	07/15/1998
WLL	US-6,027,961	02/22/2000	Maiti, Bikas , et al	438	199	06/30/1998
WLL	US-6,171,900	01/09/2001	Sun, Shi-Chung	438	240	04/15/1999
WLL	US-6,211,035	04/03/2001	Moise, Theodore , et al	438	396	09/09/1999
WLL	US-6,225,168	05/01/2001	Gardner, Mark , et al	438	287	06/04/1998
WLL	US-6,297,539	10/02/2001	Ma, Y. , et al	257	410	07/06/2000
WLL	US-6,303,481	10/16/2001	Park, Dong	438	591	12/29/2000
WLL	US-6,368,941	04/09/2002	Chen, Tai-Ju , et al	438	424	11/08/2000
WLL	US-6,387,712	05/14/2002	Yano, Y. , et al	438	3	12/03/1999

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Foreign Document No	Publication Date	Name of Patentee or Applicant of cited Document	Class	Subclass	T ²
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OTHER DOCUMENTS -- NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
WLL		OHTING, MILTON., "The Materials Science of Thin Films", Academic Press INC., (1992), 118, 121, 125	

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Walter L. Lindsay

DATE CONSIDERED

1/23/03